

L Number	Hits	Search Text	DB	Time stamp
7	16	bolometer and (bias adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 11:35
8	8	bolometer same (bias adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 11:59
9	5922	transistor same (bias adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 11:59
10	8127	transistor same (bias adj current)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:00
11	12	(transistor same (bias adj current)) and bolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 11:59
12	1000	transistor same (biasing adj current)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:01
13	0	(transistor same (biasing adj current)) same bolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:01
14	1	(transistor same (biasing adj current)) and bolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:01
15	3	transistor same (biasing adj amount)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:06
16	25456	resistor and calibrat\$	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:06
17	4714	resistor with calibrat\$	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:06
18	18	(resistor with calibrat\$) and bolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:06
19	4	(resistor with calibrat\$) and microbolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:14
20	130481	voltage adj source	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:15

21	13	(voltage adj source) same microbolometer and coupled	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 12:15
-	4	4947057.pn 5756999.pn. 6028309.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 10:24
-	6	4947057.pn. 5756999.pn. 6028309.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 11:32
-	891	250/336.1.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 11:32
-	1695	250/338.1.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 12:29
-	2548	250/336.1.ccls. or 250/338.1.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 12:29
-	231	(250/336.1.ccls. or 250/338.1.ccls.) and (microbolometer or bolometer or (thermal adj (sensor or detector or photodetector or photosensor)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 16:46
-	6993	(microbolometer or bolometer or (thermal adj (sensor or detector or photodetector or photosensor)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 12:31
-	966	((microbolometer or bolometer or (thermal adj (sensor or detector or photodetector or photosensor)))) and calibrat\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 12:34
-	57	((250/336.1.ccls. or 250/338.1.ccls.) and (microbolometer or bolometer or (thermal adj (sensor or detector or photodetector or photosensor)))) and calibrat\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 12:31
-	2	6028309.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:05
-	5	6028309.URPN.	USPAT	2003/11/03 12:34
-	5	("5286976" "5367167" "5486698" "5489776" "5554849").PN.	USPAT	2003/11/03 12:34
-	0	indigo.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:05
-	413	indigo.as.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:10

-	0	(VP adj indigo).as.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:10
-	0	(VP adj indigo).as.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:10
-	19	(indigo adj systems).as.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:25
-	4	(variable adj resistor) and (bolometer or microbolometer or (thermal adj (detector or sensor or photosensor or photodetector))) and (bias\$3 adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:38
-	41	Variable adj resistor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:37
-	1629	bolometer or microbolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:37
-	0	(bolometer or microbolometer) and (Variable adj resistor)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:38
-	0	(Variable adj resistor) and (bolometer or microbolometer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:38
-	29	(variable adj resistor) and (bolometer or microbolometer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 16:06
-	1	((variable adj resistor) and (bolometer or microbolometer)) and (bias adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 15:39
-	26	6028309.pn. 5021663.pn. 4501967.pn. 6064066.pn. 6367972.pn. 6392232.pn. 6267501.pn. 6476392.pn. 6538250.pn. 5554849.pn. 5286976.pn. 6300616.pn. 5489776.pn. 56344651.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 16:08
-	2	315855.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 16:59
-	1285	(load adj current) and (variable adj resistor)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 17:00
-	573	((load adj current) and (variable adj resistor)) and (bolometer or microbolometer or sensor or photosensor or photodetector or detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 17:00

-	238	((load adj current) and (variable adj resistor)) and (bolometer or microbolometer or sensor or photosensor or photodetector or detector)) and bias	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/11/03 17:01
-	32	((load adj current) and (variable adj resistor)) and (bolometer or microbolometer or sensor or photosensor or photodetector or detector)) and (bias\$3 adj circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 06:33
-	11	(first adj bolometer) and (second adj bolometer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 11:35
-	2	(array near2 microbolometer) and (temperature adj compensation) and (variable adj resistor)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:04
-	21	(array near2 microbolometer) and (temperature adj compensation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:04
-	9	((array near2 microbolometer) and (temperature adj compensation)) and resistor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:35
-	2	biasing adj circuit same microbolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:35
-	2	(biasing adj circuit) same microbolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:35
-	3	(bias adj circuit) same microbolometer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:37
-	113	microbolometer and calibrat\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:38
-	32	microbolometer same calibrat\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:46
-	445378	(microbolometer same calibrat\$3) and offset and variable resistor	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:42
-	1	(microbolometer same calibrat\$3) and offset and (variable adj resistor)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:42
-	0	(active adj bolometer) and (reference adj bolometer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/12/15 09:47

-	1	(active adj microbolometer) and (reference adj microbolometer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/12/15 09:47
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